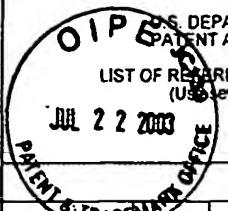


FORM PTO 1449 (modified)  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) JUL 22 2003			ATTY DOCKET NO. 03560.003310		APPLICATION NO. 10/601,777		
			APPLICANT Tadashi Okamoto et al.				
			FILING DATE Jun 24, 2003		GROUP 1631 N.Y.A.		
U.S. PATENT DOCUMENTS							
*EXAMINER'S INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
EDJ	5,405,783	04/11/95	Pirrung et al.	436	518		
↓	5,601,980	02/11/97	Gordon et al.	435	6		
↓	6,384,237 B1	05/07/02	Suzuki et al.	549	13		
↓	6,476,215 B1	11/05/02	Okamoto et al.	536	25.3		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
EDJ	JP 11-187900	07/13/99	Japan	—	—	Abstract	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EDJ	Mark Schena et al., "Quantitative Monitoring of Gene Expression Patterns with a Complementary DNA Microarray," 270 Science 467-470 (October 1995).						
↓	H.F. Arlinghaus et al., "TOF-SIMS Characterization of DNA and PNA Biosensor Chips," Proceedings of the 12 th International Conference on Secondary Ion Mass Spectrometry, pp. 951-954 (September 1999).						
EXAMINER 	DATE CONSIDERED 05/13/05						

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1